



### 30V P-CHANNEL ENHANCEMENT MODE MOSFET POWERDI<sup>®</sup>

### **Product Summary**

| V <sub>(BR)DSS</sub> | R <sub>DS(ON)</sub> Max        | I <sub>D</sub> Max<br>T <sub>A</sub> = +25°C |  |  |
|----------------------|--------------------------------|--|--|--|
| -30V                 | 10mΩ @ V <sub>GS</sub> = -10V  | -11.5A                                       |  |  |
|                      | 18mΩ @ V <sub>GS</sub> = -4.5V | -8.7A  |  |  |

### **Description**

This MOSFET is designed to minimize the on-state resistance (RDS(ON)), yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

# **Applications**

- Backlighting
- **Power Management Functions**
- DC-DC Converters

### **Features and Benefits**

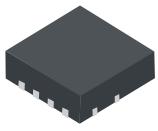
- Low R<sub>DS(ON)</sub> Ensures On-State Losses Are Minimized
- Small form factor thermally efficient package enables higher density end products
- Occupies just 33% of the board area occupied by SO-8 enabling smaller end product
- **ESD Protected Gate**
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP capable (Note 4)

### **Mechanical Data**

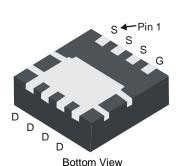
- Case: POWERDI®3333-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram Terminals: Finish - Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.072 grams (Approximate)

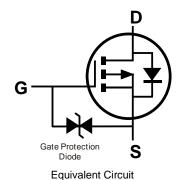
#### POWERDI3333-8











## Ordering Information (Note 5)

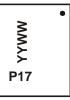
| Part Number    | Case          | Packaging         |  |  |
|----------------|---------------|-------------------|--|--|
| DMP3017SFGQ-7  | POWERDI3333-8 | 2,000/Tape & Reel |  |  |
| DMP3017SFGQ-13 | POWERDI3333-8 | 3,000/Tape & Reel |  |  |

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green"
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www.diodes.com/quality/product\_compliance\_definitions/
- 5. For packaging details, go to our website at http://www.diodes.com/products/packages.html



# **Marking Information**



P17= Product Type Marking Code YYWW = Date Code Marking YY = Last digit of year (ex: 13 = 2013) WW = Week code (01 ~ 53)

# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic   | Symbol          | Value                            | Units           |                |    |
|--|-----------------|----------------------------------|-----------------|----------------|----|
| Drain-Source Voltage                                     |                 |                                  | $V_{DSS}$       | -30            | V  |
| Gate-Source Voltage                                      |                 |                                  | $V_{GSS}$       | ±25            | V  |
| Continuous Prain Correct (Nato 7) // 40)/                | Steady<br>State | $T_A = +25$ °C<br>$T_A = +70$ °C | I <sub>D</sub>  | -11.5<br>-9.4  | А  |
| Continuous Drain Current (Note 7) V <sub>GS</sub> = -10V | t<10s           | $T_A = +25$ °C<br>$T_A = +70$ °C | I <sub>D</sub>  | -15.2<br>-12.1 | А  |
| Maximum Continuous Body Diode Forward Current (Note 6)   |                 |                                  | I <sub>S</sub>  | -3.0           | A  |
| Pulsed Drain Current (10µs pulse, duty cycle = 1%)       |                 |                                  | I <sub>DM</sub> | -80            | A  |
| Avalanche Current (Note 8) L = 1mH                       |                 |                                  | I <sub>AR</sub> | 14             | А  |
| Repetitive Avalanche Energy (Note 8) L = 1mH             |                 |                                  | E <sub>AR</sub> | 104            | mJ |

## **Thermal Characteristics**

| Characteristic                                   |                        | Symbol                            | Value       | Units |  |
|--|------------------------|-----------------------------------|-------------|-------|--|
| Total Dawer Dissination (Note 6)                 | T <sub>A</sub> = +25°C | Б                                 | 0.94        | W     |  |
| Total Power Dissipation (Note 6)                 | T <sub>A</sub> = +70°C | $P_{D}$                           | 0.6         |       |  |
| Thermal Decistores Innetion to Ambient (Note 6)  | Steady State           | Б                                 | 137         | °C/W  |  |
| Thermal Resistance, Junction to Ambient (Note 6) | t<10s                  | $R_{	heta JA}$                    | 82          | °C/W  |  |
| Total Daylar Dissination (Note 7)                | $T_A = +25$ °C         | Б                                 | 2.2         | W     |  |
| Total Power Dissipation (Note 7)                 | $T_A = +70^{\circ}C$   | $P_{D}$                           | 1.3         |       |  |
| Thormal Posistance Junction to Ambient (Note 7)  | Steady State           | В                                 | 60          | °C/W  |  |
| Thermal Resistance, Junction to Ambient (Note 7) | t<10s                  | $R_{	hetaJA}$                     | 36          | °C/W  |  |
| Thermal Resistance, Junction to Case (Note 7)    |                        | R <sub>0</sub> JC                 | 3.0         | °C/W  |  |
| Operating and Storage Temperature Range          |                        | T <sub>J</sub> , T <sub>STG</sub> | -55 to +150 | °C    |  |

Notes:

- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout, please see http://www.diodes.com/datasheets/ap02001.pdf for latest version.
- 7. Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate.
- 8.  $I_{AR}$  and  $E_{AR}$  rating are based on low frequency and duty cycles to keep  $T_{J}$  = +25°C

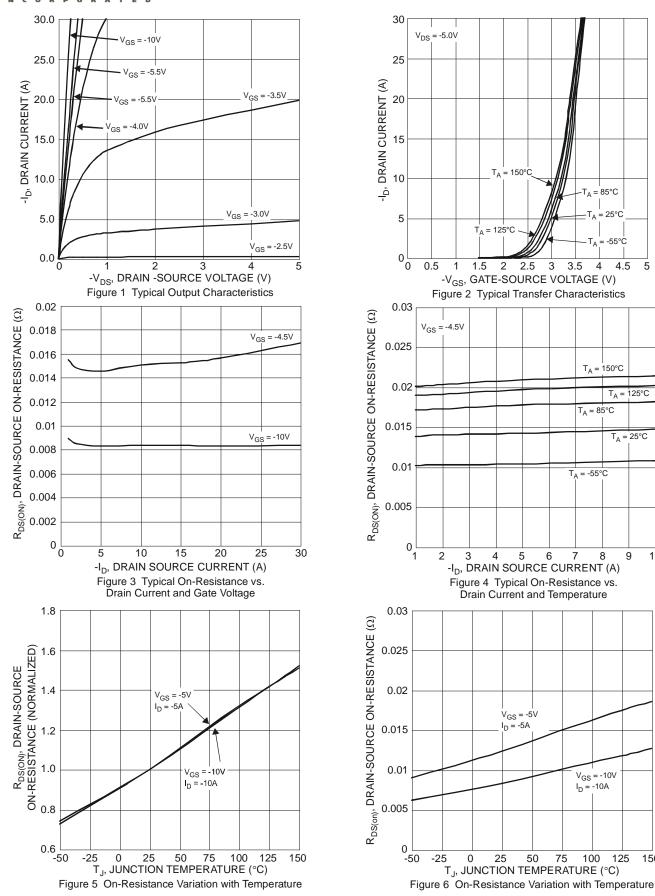


# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic                            | Symbol              | Min  | Тур  | Max  | Unit | Test Condition                                  |  |
|---|---------------------|------|------|------|------|---|--|
| OFF CHARACTERISTICS (Note 9)              |                     |      |      |      |      |   |  |
| Drain-Source Breakdown Voltage            | BV <sub>DSS</sub>   | -30  | _    | _    | V    | $V_{GS} = 0V, I_{D} = -250\mu A$                |  |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>    | _    | _    | -1   | μA   | $V_{DS} = -24V, V_{GS} = 0V$                    |  |
| Gate-Source Leakage                       | I <sub>GSS</sub>    | _    | _    | ±10  | μA   | $V_{GS} = \pm 25V, V_{DS} = 0V$                 |  |
| ON CHARACTERISTICS (Note 9)               |                     |      |      |      |      |   |  |
| Gate Threshold Voltage                    | $V_{GS(th)}$        | -1.0 | _    | -3.0 | V    | $V_{DS} = V_{GS}, I_D = -250 \mu A$             |  |
| Static Drain-Source On-Resistance         | 5                   | _    | 8.5  | 10   | mΩ   | $V_{GS} = -10V, I_D = -11.5A$                   |  |
| Static Dialii-Source On-Resistance        | R <sub>DS(ON)</sub> | _    | 15   | 18   |      | $V_{GS} = -4.5V$ , $I_D = -8.5A$                |  |
| Forward Transfer Admittance               | Y <sub>fs</sub>     | _    | 24   | _    | S    | $V_{DS} = -5V, I_D = -11.5A$                    |  |
| DYNAMIC CHARACTERISTICS (Note 10)         |                     |      |      |      |      |   |  |
| Input Capacitance                         | C <sub>iss</sub>    | _    | 2246 | _    | pF   |   |  |
| Output Capacitance                        | Coss                | _    | 352  | _    | pF   | $V_{DS} = -15V, V_{GS} = 0V,$<br>- f = 1.0MHz   |  |
| Reverse Transfer Capacitance              | C <sub>rss</sub>    | _    | 294  | _    | pF   | -1 = 1.0ivii iz                                 |  |
| Gate resistance                           | Rg                  | _    | 5.1  | 12   | Ω    | $V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$          |  |
| Total Gate Charge (V <sub>GS</sub> = 5V)  | Qg                  | _    | 20.5 | _    | nC   |   |  |
| Total Gate Charge (V <sub>GS</sub> = 10V) | Qg                  | _    | 41   | _    | nC   | 1, 45, 44, 54                                   |  |
| Gate-Source Charge                        | Q <sub>gs</sub>     | _    | 7.6  | _    | nC   | $V_{DS} = -15V, I_{D} = -11.5A$                 |  |
| Gate-Drain Charge                         | Q <sub>gd</sub>     | _    | 8.0  | _    | nC   |   |  |
| Turn-On Delay Time                        | t <sub>D(on)</sub>  | _    | 7.5  | _    | nS   |   |  |
| Turn-On Rise Time                         | t <sub>r</sub>      | _    | 15.4 | _    | nS   | V <sub>DD</sub> = -15V, V <sub>GS</sub> = -10V, |  |
| Turn-Off Delay Time                       | t <sub>D(off)</sub> | _    | 45.6 | _    | nS   | $R_G = 6\Omega$ , $I_D = -11.5A$                |  |
| Turn-Off Fall Time                        | t <sub>f</sub>      | _    | 36.8 | _    | nS   |   |  |
| BODY DIODE CHARACTERISTICS                |                     |      |      |      |      |   |  |
| Diode Forward Voltage                     | $V_{SD}$            | _    | -0.7 | _    | V    | $V_{GS} = 0V, I_{S} = -1A$                      |  |
| Reverse Recovery Time (Note 9)            | t <sub>rr</sub>     | _    | 20   | _    | nS   |   |  |
| Reverse Recovery Charge (Note 9)          | Qrr                 | _    | 9.5  | _    | nC   | I <sub>S</sub> = -11.5A, dI/dt = 100A/μs        |  |

 Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing. Notes:





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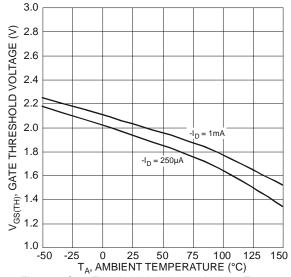
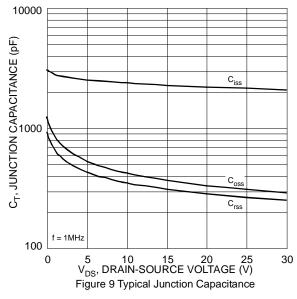


Figure 7 Gate Threshold Variation vs. Ambient Temperature



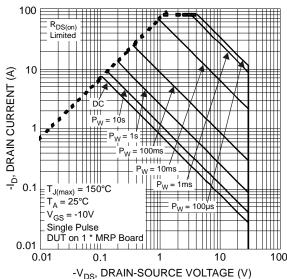
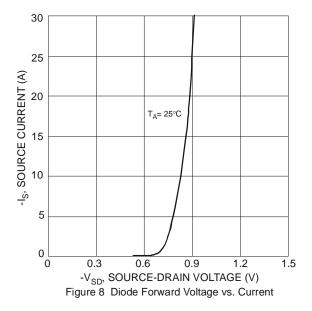
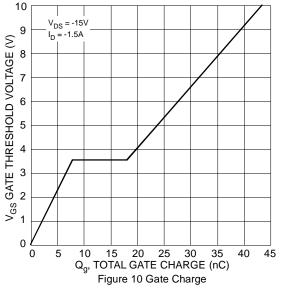


Figure 11 SOA, Safe Operation Area







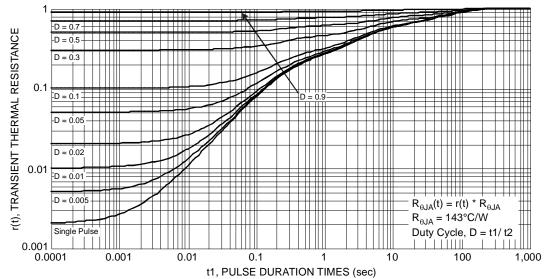
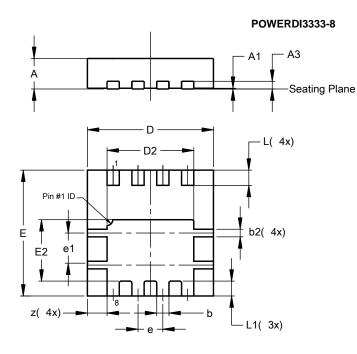


Figure 12 Transient Thermal Resistance



# **Package Outline Dimensions**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

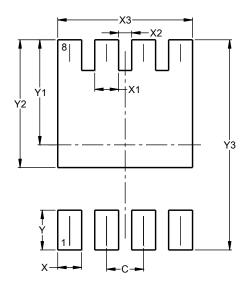


| POWERDI®3333-8       |      |      |       |  |  |  |
|----------------------|------|------|-------|--|--|--|
| Dim                  | Min  | Max  | Тур   |  |  |  |
| Α                    | 0.75 | 0.85 | 0.80  |  |  |  |
| A1                   | 0.00 | 0.05 | 0.02  |  |  |  |
| A3                   | _    | _    | 0.203 |  |  |  |
| b                    | 0.27 | 0.37 | 0.32  |  |  |  |
| b2                   | _    | _    | 0.20  |  |  |  |
| D                    | 3.25 | 3.35 | 3.30  |  |  |  |
| D2                   | 2.22 | 2.32 | 2.27  |  |  |  |
| E                    | 3.25 | 3.35 | 3.30  |  |  |  |
| E2                   | 1.56 | 1.66 | 1.61  |  |  |  |
| е                    | _    | _    | 0.65  |  |  |  |
| e1                   | 0.79 | 0.89 | 0.84  |  |  |  |
| L                    | 0.35 | 0.45 | 0.40  |  |  |  |
| L1                   | -    | _    | 0.39  |  |  |  |
| Z                    | _    | _    | 0.515 |  |  |  |
| All Dimensions in mm |      |      |       |  |  |  |

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

### POWERDI3333-8



| Dimensions | Value (in mm) |
|------------|---------------|
| C          | 0.650         |
| X          | 0.420         |
| X1         | 0.420         |
| X2         | 0.230         |
| Х3         | 2.370         |
| Υ          | 0.700         |
| Y1         | 1.850         |
| Y2         | 2.250         |
| Y3         | 3.700         |



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